

FDZ204P

P-Channel 2.5V Specified PowerTrench® BGA MOSFET

General Description

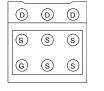
Combining Fairchild's advanced 2.5V specified PowerTrench process with state of the art BGA packaging, the FDZ204P minimizes both PCB space and $R_{\rm DS(ON)}$. This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultralow profile packaging, low gate charge, and low $R_{\rm DS(ON)}$.

Applications

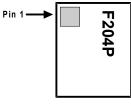
- · Battery management
- · Load switch
- · Battery protection

Features

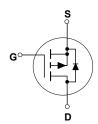
- -4.5 A, -20 V. $R_{DS(ON)}$ = 45 m Ω @ V_{GS} = -4.5 V $R_{DS(ON)}$ = 75 m Ω @ V_{GS} = -2.5 V
- Occupies only 4 mm² of PCB area.
 Less than 40% of the area of a SSOT-6
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- Ultra-low Q_q x R_{DS(ON)} figure-of-merit.
- High power and current handling capability.







Top



Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		-20	V
V_{GSS}	Gate-Source Voltage		±12	V
I _D	Drain Current - Continuous	(Note 1a)	-4.5	A
	- Pulsed		-20	
P _D	Power Dissipation (Steady State)	(Note 1a)	1.8	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	67	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball	(Note 1)	11	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	1	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
204P	FDZ204P	7"	8mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-20			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		-17		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μΑ
GSSF	Gate-Body Leakage, Forward	$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS} = 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
On Char	racteristics (Note 2)					
/ _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.6	-0.9	-1.5	V
$\Delta V_{GS(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	I_D = –250 μA, Referenced to 25°C		3		mV/°C
R _{DS(on)}	Static Drain-Source	$V_{GS} = -4.5 \text{ V}, I_{D} = -4.5 \text{ A}$		37	45	mΩ
	On–Resistance	$V_{GS} = -2.5 \text{ V}, I_{D} = -3.5 \text{ A}$		57	75	
		$V_{GS} = -4.5 \text{ V}, I_D = -4.5 \text{A}, T_J = 125^{\circ}\text{C}$ $V_{DS} = -5 \text{ V}, I_D = -4.5 \text{ A}$		50	65	
g _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -4.5 \text{ A}$		15		S
Dynamio	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		884		pF
Coss	Output Capacitance	f = 1.0 MHz		258		pF
C _{rss}	Reverse Transfer Capacitance			103		pF
Switchir	ng Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -6 \text{ V}, \qquad I_{D} = -1 \text{ A},$		12	22	ns
r	Turn-On Rise Time	$V_{DD} = -6 \text{ V}, \qquad I_{D} = -1 \text{ A}, \\ V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		9	18	ns
$t_{d(off)}$	Turn-Off Delay Time	1		36	58	ns
t _f	Turn-Off Fall Time			24	38	ns
Q_{q}	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -4.5 \text{ A},$		9	13	nC
Q_{qs}	Gate-Source Charge	V _{GS} = -4.5 V		2		nC
Q_{gd}	Gate-Drain Charge			3		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain-Sourc	•			-1.5	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.5 \text{ A} \text{(Note 2)}$		-0.76	-1.2	V
·rr	Diode Reverse Recovery Time	$I_F = -5.5 \text{ A},$		25		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		26		nC

Notes:

 $R_{\theta,JA}$ is determined with the device mounted on a 1 in 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, R_{0JB} , is defined for reference. For R_{0JC} , the thermal reference point for the case is defined as the top surface of the copper chip carrier. $R_{\theta JC}$ and $R_{\theta JB}$ are guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.



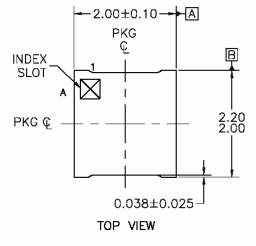
67 °C/W when mounted on a 1in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB

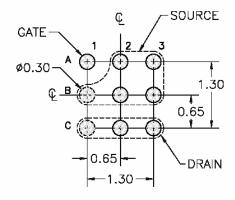


155 °C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper 2. 2. Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%

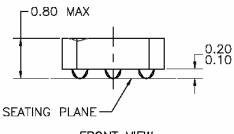
Dimensional Outline and Pad Layout



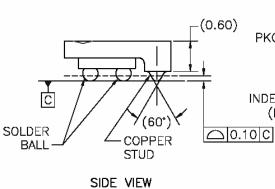


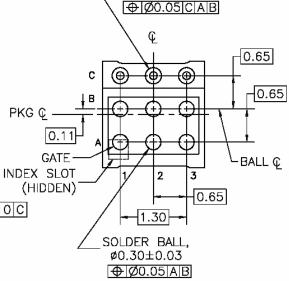
LAND PATTERN RECOMMENDATION

COPPER STUD, Ø0.32±0.03









NOTES: UNLESS OTHERWISE SPECIFIED

- A) ALL DIMENSIONS ARE IN MILLIMETERS.
- B) NO JEDEC REGISTRATION REFERENCE AS OF JULY 1999.
- C) TERMINAL CONFIGURATION TABLE.

POSITION	DESIGNATION	TYPE
C1,C2,C3	DRAIN	COPPER STUD
A1	GATE	SOLDER
A2,A3,B1,B2,B3	SOURCE	BALL

Typical Characteristics

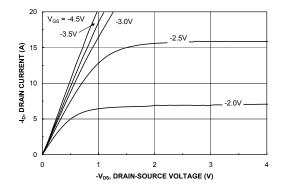


Figure 1. On-Region Characteristics.

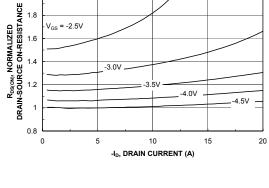


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

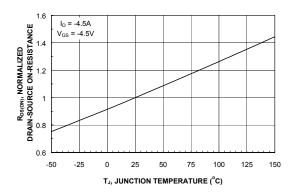


Figure 3. On-Resistance Variation with Temperature.

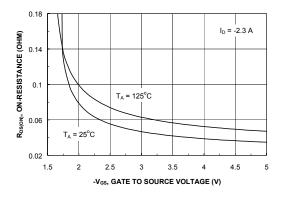


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

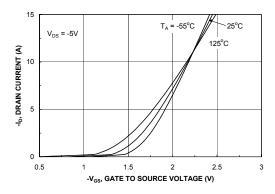


Figure 5. Transfer Characteristics.

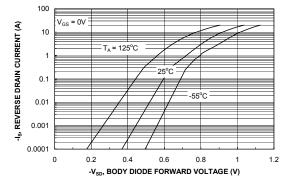
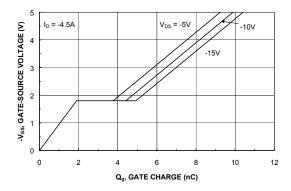


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



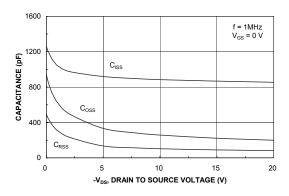
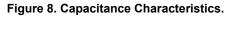
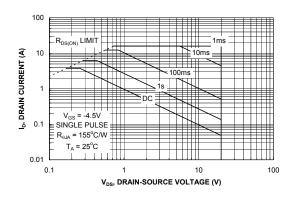


Figure 7. Gate Charge Characteristics.





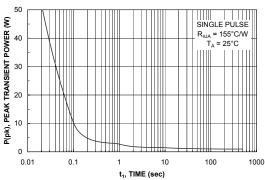


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

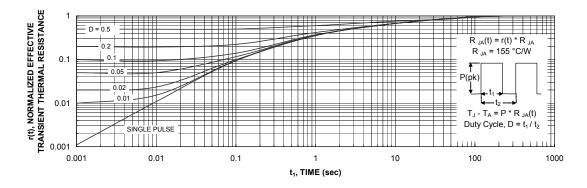


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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